

<b>Issue Classification</b>	Application/Control No.	Applicant(s)/Patent under Reexamination
	10/697,489	CHIBA ET AL.
	Examiner	Art Unit
	Jaydi A. Aguirrechea	2834

## ISSUE CLASSIFICATION

ORIGINAL				CROSS REFERENCE(S)							
CLASS		SUBCLASS		CLASS		SUBCLASS (ONE SUBCLASS PER BLOCK)					
310		370		310		328	330				
INTERNATIONAL CLASSIFICATION				333		200					
H	0	3	H	9/21							
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<b>J. AGUIRRECHEA</b> 4/12/05 (Assistant Examiner) (Date)				<b>DARREN SCHUBERG</b> <b>SUPERVISORY PATENT EXAMINER</b> <b>TECHNOLOGY CENTER 2800</b> (Primary Examiner) (Date)				Total Claims Allowed: 9			
<i>Dominic Ercan</i> 4/19/05 (Legal Instruments Examiner) (Date)								O.G. Print Claim(s) 1		O.G. Print Fig. 5	

<input type="checkbox"/> Claims renumbered in the same order as presented by applicant		<input type="checkbox"/> CPA		<input type="checkbox"/> T.D.		<input type="checkbox"/> R.1.47	
Final	Original	Final	Original	Final	Original	Final	Original
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3	5	35	65	95	125	155	185
6	6	36	66	96	126	156	186
7	7	37	67	97	127	157	187
8	8	38	68	98	128	158	188
9	9	39	69	99	129	159	189
10		40	70	100	130	160	190
11		41	71	101	131	161	191
12		42	72	102	132	162	192
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26		56	86	116	146	176	206
27		57	87	117	147	177	207
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